1200 VOLT, 40 AMP MOSFET FULL-BRIDGE MODULE

Features:

- Electrically isolated, base-less construction
- Light weight low profile standard package
- Aluminum Nitride substrate
- High temperature engineering plastic shell construction



LECTRIC	TRICAL CHARACTERISTICS PER MOSFET LEG		(T _J =25°C UNLESS OTHERWISE SPECIFIED)				
SYMBOL	PARAMETER	MIN	TYP	MAX	UNIT		
MOSFET S	SPECIFICATIONS						
BV _{DSS}	Drain to Source Breakdown Voltage $I_D = 100 \mu A, V_{GS} = 0 V$	1200	-	-	V		
I _D	Continuous Drain Current $T_C = 25^{\circ}C$ $T_C = 100^{\circ}C$	-	-	60 40	А		
I _{D(pulse)}	Pulsed Drain Current, pulse width tp limited by tjmax	-	-	120	Α		
VGS	Gate to Source Voltage static dynamic	-	-	-4/+15 8/+19	V		
Igss	Gate-Source Leakage Current , V _{GS} = +15V / -4V, V _{DS} = 0V	-	10	250	nA		
V _{GS(th)}		1.8 -	2.5 2.1	3.6	V		
I _{DSS}	Zero Gate Voltage Drain Current V _{DS} = 1200 V, V _{GS} =0V	-	1	50	μA		
R _{DS(on)}	Drain-Source On-State Resistance $T_J = 25^{\circ}\text{C}$ $I_D = 40\text{A}, V_{GS} = 15\text{V}$ $T_J = 150^{\circ}\text{C}$	22	32 58	43	mΩ		
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Cap. VDS = 200 V, VGS = 0 V, f = 100 kHz, VAC = 25 mV		3357 250 12	- - -	pF		
tD(on) tR tD(off) tF	Turn On Delay Time Rise Time Turn Off Delay Time Fall Time $V_{DS} = 800 \text{ V}, \text{ I}_{D} = 20 \text{A}, \text{ V}_{GS} = -4/+15 \text{V}, \text{ R}_{G} = 2.5 \Omega$ Timing relative to V_{DS} , inductive load	- - - -	15 52 26 34	- - - -	ns		
E _{OFF}	Turn on Energy Loss Turn off Energy Loss $V_{DS} = 600 \text{ V}, I_D = 40A, V_{GS} = -4/+15V, R_G = 2.5\Omega, L=65.7\mu\text{H}$	-	325 50	-	μJ		
R _{G(int)}	Internal Gate Resistance f = 1MHz, V _{AC} = 25mV	-	1.7		Ω		
Qgs Qgd Qg	Gate to Source Charge Gate to Drain Charge Total Gate Charge VDS = 800 V, ID = 40A, VGS = -4/+15V	-	40 34 118	-	nC		



REVERSE DIODE CHARACTERISTICS

(T_J=25 °C UNLESS OTHERWISE SPECIFIED)

SYMBOL	PARAMETER	MIN	TYP	MAX	UNIT		
DIODE SPECIFICATIONS							
V _{SD}	$ \begin{array}{ccc} \mbox{Diode Forward Voltage} & \mbox{T}_{\mbox{\scriptsize J}} = 25^{\circ}\mbox{C} \\ \mbox{V}_{\mbox{\scriptsize GS}} = -4\mbox{V}, \mbox{I}_{\mbox{\scriptsize JD}} = 20\mbox{A} & \mbox{T}_{\mbox{\scriptsize J}} = 150^{\circ}\mbox{C} \\ \end{array} $	-	4.6 4.2		V		
Is	Continuous Forward Current T _J = 25°C	-	60		Α		
t _{rr}	Reverse Recovery Time $V_{GS} = -4V$, $I_{SD} = 40A$, $V_{R} = 800V$, $di/dt = 2250A/ \mu s$	-	27	-	ns		
Qrr	Reverse Recovery Charge $V_{GS} = -4V$, $I_{SD} = 40A$, $V_{R} = 800V$, $di/dt = 2250A/ \mu s$	-	478	-	nC		
I _{rrm}	Peak Reverse Recovery Current $V_{GS} = -4V$, $I_{SD} = 40A$, $V_{R} = 800V$, $di/dt = 2250A/ \mu s$	-	27	-	А		

ZVS SIC DIODE CHARACTERISTICS

(T_J=25°C UNLESS OTHERWISE SPECIFIED)

			(13-23 0 0142230 01112144132 01 2011125)				
SYMBOL	PARAMETER		MIN	TYP	MAX	UNIT	
DIODE SPECIFICATIONS							
V _{RRM}	Repetitive Peak Reverse Voltage		1200	-	-	V	
V _{RSM}	Surge Peak Reverse Voltage		1300	-	-	V	
VR	DC Peak Blocking Voltage		1200	-	-	V	
l _F	Continuous Forward Current,	T _J = 150°C	-	-	5	А	
IFRM	Repetitive Peak Forward Surge Current t _P = 10ms, Half Sine Pulse	$T_{C} = 25^{\circ}C$ $T_{C} = 110^{\circ}C$	-	-	26 18	Α	
I _{FSM}	Non-Repetitive Forward Surge Current tp = 10ms, Half Sine Pulse	T _C = 25°C T _C = 110°C	-	-	46 36	Α	
V _F	Forward Voltage I _F = 5A	T _J = 25°C T _J = 150°C	-	1.4 1.9	1.8 3.0	V	
IR	Reverse Current V _R = 1200V	T _J = 25°C T _J = 150°C	-	20 40	150 300	μΑ	
Qc	Total Capacitive Charge $V_{R=}$ 800V, I_{F} = 5A, di/dt = 200A/ μ s, T_{J} = 25 °C		-	27	-	nC	
С	Total Capacitance $V_R = 0V$, $T_J = 25$ °C, $f = 1MHz$ $V_R = 400V$, $T_J = 25$ °C, $f = 1MHz$ $V_R = 800V$, $T_J = 25$ °C, $f = 1MHz$		-	390 27 20	-	pF	

Note: Production units are only tested at room temperature. Low/High temperature operation is guaranteed by design.



NTC-THERMISTOR CHARACTERISTICS

(T_J=25°C UNLESS OTHERWISE SPECIFIED)

SYMBOL	PARAMETER		TYP	MAX	UNIT		
NTC SPECIFICATIONS							
R ₂₅	Resistance $T_C = 25^{\circ}C$	-	4.7	-	K Ohm		
R _{TOL}	Resistance Tolerance	-		1	%		
Р	Maximum Power Dissipation	-	1	50	mW		
B _{25/85}	NTC Thermistor Beta Value $R = R_{25}e^{B_{25/85}(\frac{1}{T} - \frac{1}{298.15})}$		3435		К		

THERMAL AND MECHANICAL CHARACTERISTICS

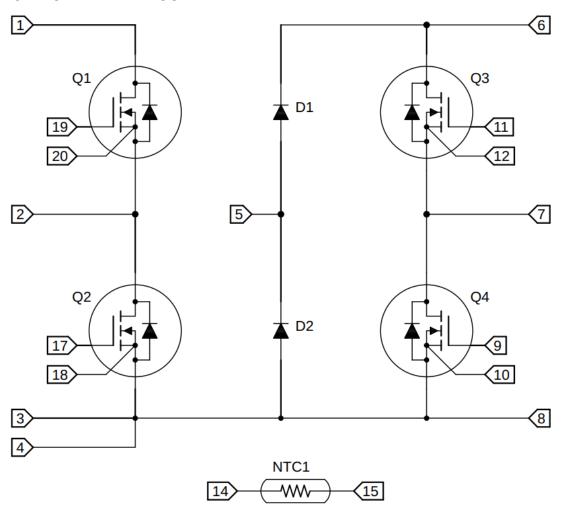
SYMBOL	PARAMETER	MIN	TYP	MAX	UNIT
R ₀ JB_M	MOSFET Junction-to-Base Plate Thermal Resistance Per Leg	-	0.45	0.60	°C/W
R ₀ JB_D	Diode Junction-to-Base Plate Thermal Resistance Per Leg	-	1.60	1.76	°C/W
V _{iso1}	All pins to Isolation to Base Plate/Screw mounting pads	-	-	2500	VDC
V _{iso2}	NTC1(Pin15&16) & NTC2(Pin13&14) to all other pins	-	-	2000	Vrms
TJ	Operating Junction Temperature	-55	-	150	°C
T _{STG}	Storage Temperature	-55	-	150	°C
	Mounting Torque for Module Mounting	3	-	4	in-lbs.
	Weight	-	10	-	g

INSTALLATION INSTRUCTIONS:

Recommended thermal interface material = Laird Tgon 805 (5 mil thick graphite pad)

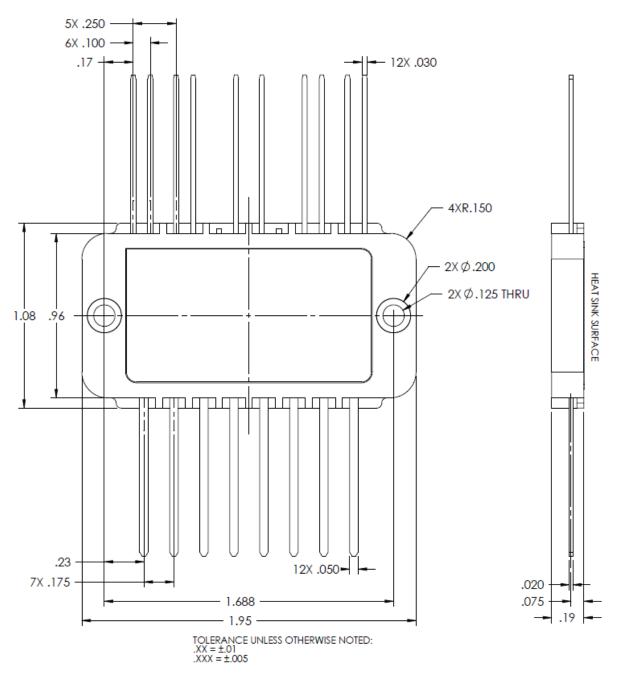
- 1. Fasten screws to 1 to 2 in-lb. of torque.
- 2. Fasten screws to final torque.

SCHEMATIC DIAGRAM AND PINOUT:



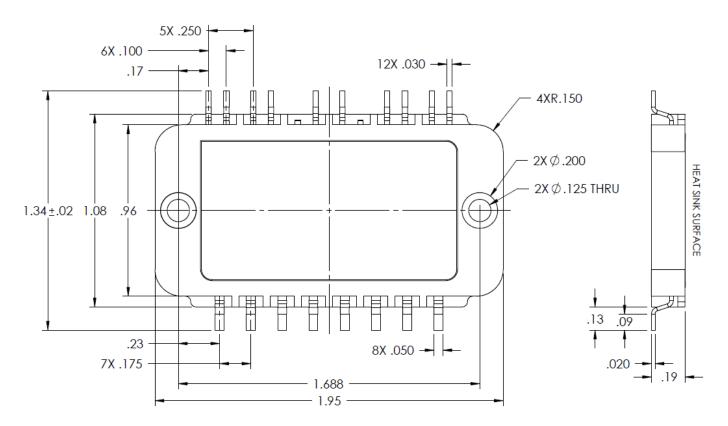
MECHANICAL OUTLINE (inches):

Part Number SPM1019C3-1 Straight Leads



PINS 13 AND 16 REMOVED

Part Number SPM1019C3-2 SMT leads, reverse mounting



TOLERANCE UNLESS OTHERWISE NOTED: .XX = ±.01 .XXX = ±.005

PINS 13 AND 16 REMOVED

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